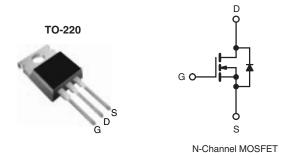


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	3.0		
Q _g (Max.) (nC)	24			
Q _{gs} (nC)	3.3			
Q _{gd} (nC)	13			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Load (Dh) free	IRF820PbF
Lead (Pb)-free	SiHF820-E3
SnPb	IRF820
SILD	SiHF820

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, ui	nless otherw	rise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	.,,	
Gate-Source Voltage			V_{GS}	± 20	- V	
Continuous Drain Current	V -+ 10 V	T _C = 25 °C		2.5	А	
	V _{GS} at 10 V	T _C = 100 °C	I _D	1.6		
Pulsed Drain Current ^a			I _{DM}	8.0	1	
Linear Derating Factor				0.40	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	210	mJ	
Repetitive Avalanche Currenta			I _{AR}	2.5	А	
Repetitive Avalanche Energy ^a			E _{AR}	5.0	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	50	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	- °C		
Soldering Recommendations (Peak Temperature)	for ⁻	10 s		300 ^d		
Mounting Torque	6.20.0**	C 00 av M0 aava		10	lbf ⋅ in	
	6-32 or M3 screw			1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, L = 60 mH, $R_G = 25 \,\Omega$, $I_{AS} = 2.5 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le 2.5$ A, $dI/dt \le 50$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	500	-	-	٧	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V _{DS} =	· V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = 500 V, V _{GS} = 0 V		-	25	μΑ
Drain-Source On-State Resistance	D	$V_{DS} = 400 \text{ V}$ $V_{GS} = 10 \text{ V}$	$I_{\rm N} = 0 \text{ V}, T_{\rm J} = 125 ^{\circ}\text{C}$ $I_{\rm D} = 1.5 ^{\circ}\text{Ab}$	-	-	250 3.0	Ω
Forward Transconductance	R _{DS(on)}		= 50 V, I _D = 1.5 A	1.5	_	3.0	S
Dynamic	yts .	V DS	- 00 V, ID - 1.0 A	1.5			
Input Capacitance	C _{iss}	T	_	360	_	pF	
Output Capacitance	C _{oss}	1	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		92		-
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	37		-
Total Gate Charge	Qq		I _D = 2.1 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	24	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	3.3	
Gate-Drain Charge	Q _{gd}			-	-	13	
Turn-On Delay Time	t _{d(on)}		V _{DD} = 250 V, I _D = 2.1 A,		8.0	_	- ns
Rise Time	t _r	V _{DD} =			8.6	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 18 \Omega$, $R_D = 100 \Omega$, see fig. 10^b		-	33	-	
Fall Time	t _f			-	16	-	
Internal Drain Inductance	L _D	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.5	-	الم
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	71. 13		-	2.5	- A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	8.0	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 51 A, V _{GS} = 0 V ^b		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 51 A, dl/dt = 100 A/μs		-	260	520	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.7	1.4	nC
Forward Turn-On Time	t _{on}	Intrinsic tu	n-on is dominated by L _S and L _D)				

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

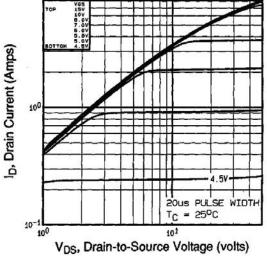


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

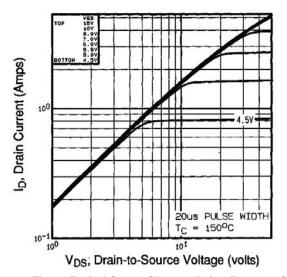


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

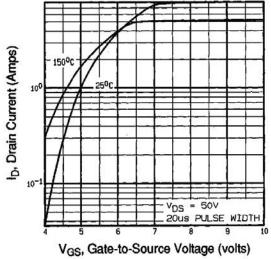


Fig. 3 - Typical Transfer Characteristics

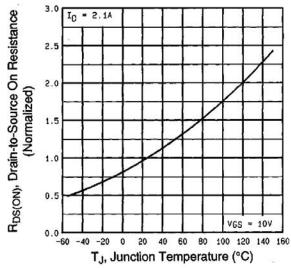


Fig. 4 - Normalized On-Resistance vs. Temperature



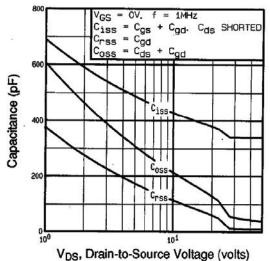


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

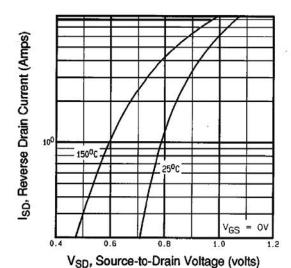


Fig. 7 - Typical Source-Drain Diode Forward Voltage

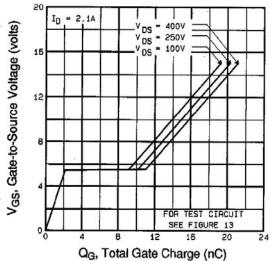


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

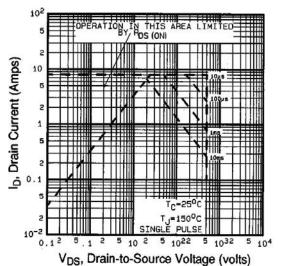


Fig. 8 - Maximum Safe Operating Area



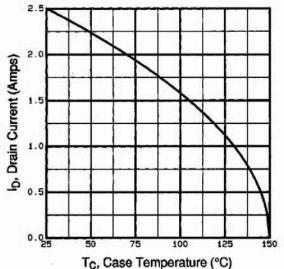


Fig. 9 - Maximum Drain Current vs. Case Temperature

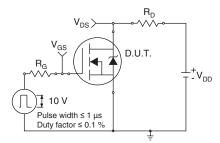


Fig. 10a - Switching Time Test Circuit

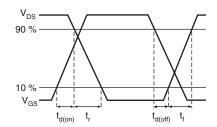


Fig. 10b - Switching Time Waveforms

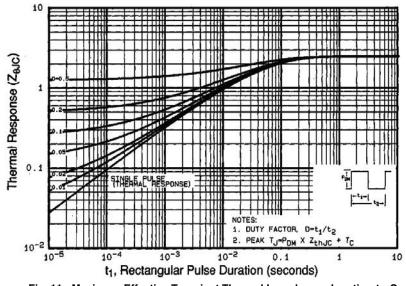


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

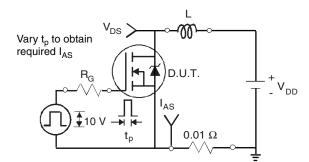


Fig. 12a - Unclamped Inductive Test Circuit

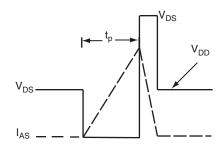


Fig. 12b - Unclamped Inductive Waveforms



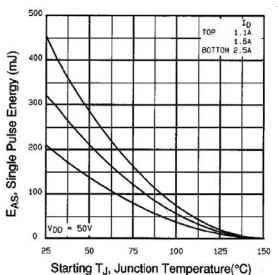


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

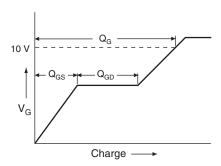


Fig. 13a - Basic Gate Charge Waveform

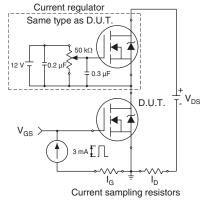
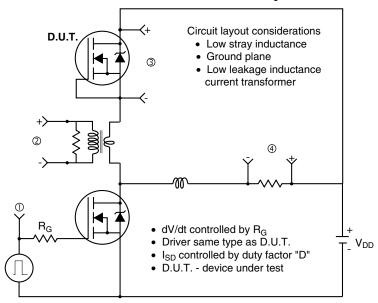
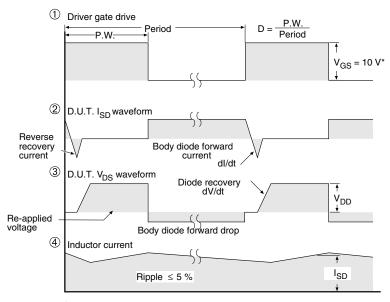


Fig. 13b - Gate Charge Test



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 -For N-Channel

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